

Search Notes

Application/Control No.

10/694,466

Examiner

Vuthe Siek

Applicant(s)/Patent under
Reexamination

GALLATIN ET AL.

Art Unit

2825

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 716 | 19-21 | 6/29/2005 | VS |
| 703 | 2,5,13 | 6/29/2005 | VS |
| 382 | 144 | 6/29/2005 | VS |
| 430 | 5 | 6/29/2005 | VS |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------------|---------------|-----------|-----------|
| SAME | SEARCH | 6/30/2005 | VS |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-------------------------------------|-----------|------|
| EAST ALL DATABASES, IEEE, GOOGLE | 6/29/2005 | VS |
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